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Hiroi, Takashi et al.

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EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS/ SUBCLASS	FILING DATE
083	5,085,517	02/92	CHADWICK et al.	356	394
0013	5,502,306	03/96	MEISBURGER et al.	250	310
1913	4,805,089	02/89	LANE et al.	364	188
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Mo	"Monthly Semiconductor World" August 1995, pp. 96-99.			
10B	"Journal of Vacuum Science Technology B", Vol.9, No.6, 1991, pp. 3005-3009.			
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EXAMINER

DATE CONSIDERED

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